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Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







Preliminary Data Sheet No. PD60083I

IR51H(D)224 IR51H(D)320

IR51H(D)420

SELF-OSCILLATING HALF BRIDGE

Features

- Output Power MOSFETs in half-bridge configuration
- High side gate drive designed for bootstrap operation
- Bootstrap diode integrated into package (HD type)
- Accurate timing control for both Power MOSFETS Matched delay to get 50% duty cycle Matched deadtime of 1.2us
- Internal oscillator with programmable frequency

$$f = \frac{1}{1.4 \times (R_T + 75\Omega) \times C_T}$$

- 15.6V Zener clamped Vcc for offline operation
- Half-bridge output is out of phase with R_T
- Micropower startup

Description

The IR51H(D)XXX are complete high voltage, high speed, self-oscillating half-bridge circuits. Proprietary HVIC and latch immune CMOS technologies, along with the HEXFET® power MOSFET technology, enable ruggedized single package construction. The front-end features a programmable oscillator which functions similar to the CMOS 555 timer. The supply to the control circuit has a zener clamp to simplify offline operation. The output features two HEXFETs in a half-bridge configuration with an internally set deadtime designed for minimum cross-conduction in the half-bridge. Propagation delays for the high and low side

Product Summary

V_{IN} (max) 250V (IR51H(D)224)

400V (IR51H(D)310)

500V (IR51H(D)420)

Duty Cycle 50%

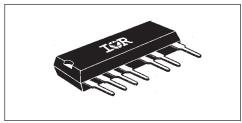
Deadtime 1.2μs

Rds(on) 1.1W (IR51H(D)224)

3.0W (IR51H(D)310) 3.6W (IR51H(D)420)

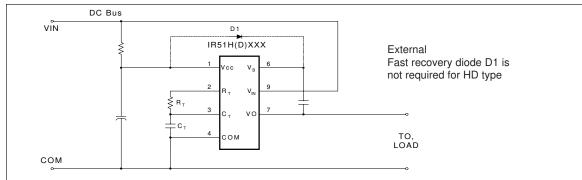
 $P_D (T_A = 25 \circ C)$ 2.0W

Package



power MOSFETs are matched to simplify use in 50% duty cycle applications. The device can operate up to 500 volts.

Typical Connection



IR51H(D)224 IR51H(D)320 IR51H(D)420

Absolute Maximum Ratings

Absolute maximum ratings indicate sustained limits beyond which damage to the device may occur. All voltage parameters are absolute voltages referenced to COM, all currents are defined positive into any lead. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions.

Symbol	Definition		Minimum	Maximum	Units
V _{IN}	High voltage supply	-224	- 0.3	250	
		-320	- 0.3	400	
		-420	- 0.3	500	
V _B	High side floating supply		Vo - 0.3	Vo +2.5	V
V _O	Half-bridge output		-0.3	$V_{IN} + 0.3$	
V_{RT}	R_T voltage		- 0.3	$V_{cc} + 0.3$	
V _{CT}	C_T voltage		- 0.3	$V_{cc} + 0.3$	
I _{cc}	Supply current (note 1)		_	25	mA
I _{RT}	R _T output current		- 5	5	111/4
dV/dt	Peak diode recovery		_	3.5	V/ns
P_D	Package power dissipation @ T _A ≤ +25°C		_	2.00	W
Rth _{JA}	Thermal resistance, junction to ambient		_	60	°C/W
TJ	Junction temperature		-55	150	
T _S	Storage temperature		-55	150	°C
T _L	Lead temperature (soldering, 10 seconds)		_	300	†

NOTE 1:

This IC contains a zener clamp structure between V_{CC} and COM which has a nominal breakdown voltage of 15.6V. Please note that this supply pin should not be driven by a DC, low impedance power source greater than the V_{CLAMP} specified in the Electrical Characteristics Section

Recommended Operating Conditions

The input/output logic timing diagram is shown in figure 1. For proper operation, the device should be used within the recommended conditions.

Symbol	Definition	Definition			Units	
V _B	High side floating supply absolute voltage		V _O + 10	Vo + Vclamp		
V _{IN}	High voltage supply	-224	_	250		
		-320	_	400	V	
		-420	_	500		
Vo	Half-bridge output voltage		-3.0 (note 2)	V _{IN}		
I _D	Continuous drain current (TA = 25°C)	-224	_	1.1		
		-320	_	0.9		
		-420	_	0.7	Α	
	$(T_A = 85^{\circ}C)$	-224	_	0.7		
		-320	_	0.6		
		-420	_	0.5		
I _{CC}	Supply current		(note 3)	5	mA	
T _A	Ambient temperature		-40	125	°C	

NOTE 2:

Care should be taken to avoid switching conditions where the Vs node flies inductively below ground by more than 5V.

NOTE 3

Enough current should be supplied to the V_{CC} lead of the IC to keep the internal 15.6V zener diode clamping the voltage at this lead.

Dynamic Electrical Characteristics

 V_{BIAS} (V_{CC} , V_{BS}) = 12V, T_A = 25°C unless otherwise specified.

Symbol	Definition		Min.	Тур.	Max.	Units	Test Cond	litions
t _{rr}	Reverse recovery time (MOSFET body diode)	-224	_	200	_		I _F =1.1A	
	_	-320	_	270	_	ns	I _{F=} 900mA	di/dt
		-420	_	240	_		I _{F=700m} A	ai/at
Q _{rr}	Reverse recovery charge (MOSFET body diode)	-224	_	0.7	_	_	I _F =1.1A	=100
	_	-320	_	0.6	_	μC	I _F =900mA	A/μs
		-420	_	0.5	_		I _F =700mA	·
D	R _T duty cycle		_	50	_	%	fosc = 20 k	Hz

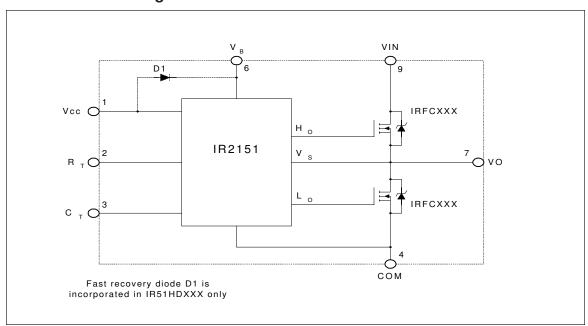
IR51H(D)224 IR51H(D)320 IR51H(D)420

Static Electrical Characteristics

 V_{BIAS} (V_{CC} , V_{B}) = 12V, T_{A} = 25°C unless otherwise specified.

Symbol	Definition		Min.	Тур.	Max.	Units	Test Cond	ditions
V _{CCUV+}	V _{cc} supply undervoltage positive going	l	_	8.4	_	V		
	threshold							
Vccuv-	V _{CC} supply undervoltage negative going		_	8.0	_	V		
	threshold							
lacc	Quiescent V _{CC} supply current		_	300	_	μΑ	V _{CC} > V _{CC}	CUV
V _{CLAMP}	V _{CC} zener shunt clamp voltage		_	15.6	_	V	$I_{CC} = 5mA$	
I _{QBS}	Quiescent V _{BS} supply current		_	30	_			
Ios	Offset supply leakage current		_	_	50	μΑ	$V_B = V_{IN} =$	500V
fosc	Oscillator frequency		_	20	_		$R_T = 35.7$	kΩ
						kHz	$C_T = 1 nF$	
			_	100	_	KIZ	$R_T = 7.04$	
							$C_T = 1 \text{ nF}$:
I _{CT}	C _T input current		_	0.001	1.0	μA		
V _{CTUV}	C _T undervoltage lockout		_	100	_		Note 2	
V_{RT+}	R_T high level output voltage, V_{CC} - R_T		_	20	_		$I_{RT} = 100\mu$	
			_	200	_	mV	$I_{RT} = -1mA$	١
V_{RT-}	R _T low level output voltage		_	20	-	''''	$I_{RT} = 100\mu$	
			_	200	_		$I_{RT} = -1mA$	١
V_{RTUV}	R _T undervoltage lockout, V _{CC} - R _T			100			$I_{RT} = 100\mu$	A
V_{CT+}	2/3 V _{CC} threshold		_	8.0	_	kHz		
V _{CT-}	1/3 V _{CC} threshold		_	4.0	_	KIIZ		
Rds(on)	Static-drain-to-source on-resistance	-224	_	1.1	_		I _F =1.1A	
	_	-320	_	1.8	_	Ω	I _{F=} 900mA	di/dt
		-420	_	3.0	_		I _{F=} 700mA	400
V_{SD}	Diode forward voltage	-224	_	0.85	_		I _F =1.1A	=100
		-320	_	0.7	_	V	I _F =900mA	A/μs
		-420	_	0.8	_		I _F =700mA	

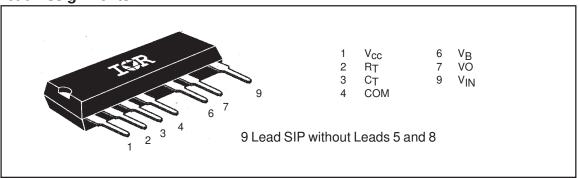
Functional Block Diagram



Lead Definitions

Symbol	Lead Description
V _{CC}	Logic and internal gate drive supply voltage. An internal zener clamp diode at 15.6 V norminal is included to allow the V_{CC} to be current fed directly from VIN typically by means of a high value resistor.
R _T	Oscillator timing resistor output; a resistor is connected from R_T to C_T . RT is out of phase with the half-bridge output (VO).
C _T	Oscillator timing capacitor input; a capacitor is connected from C_T to COM in order to program the oscillator frequency according to the following equation: $f = \frac{1}{1.4 \times (R_T + 75\Omega) \times C_T}$ C_T PIN also invokes shutdown function (see note 2) where 75Ω is the effective impedence of the R_T output stage.
V _B	High side gate drive floating supply. For bootstrap operation a high voltage fast recovery diode is needed to feed from V_{CC} to V_{B} . (HD type circuits incorporate this diode).
V_{IN}	High voltage supply
VO	Half Bridge output
COM	Logic and low side of half bridge return

Lead Assignments



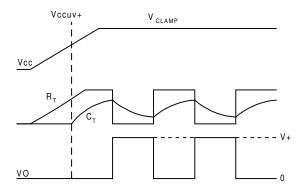
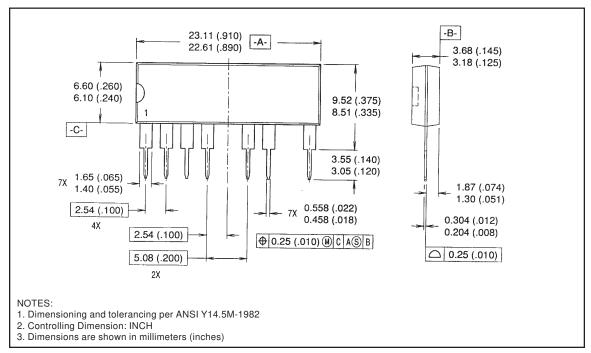


Figure 1. Input/Output Timing Diagram

Case Outline - 9 Lead SIP



International Rectifier

WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245 Tel: (310) 322 3331

IR GREAT BRITAIN: Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

IR CANADA: 15 Lincoln Court, Brampton, Ontario L6T 3Z2 Tel: (905) 453-2200

IR GERMANY: Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

IR ITALY: Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

IR FAR EAST: K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo, Japan 171 Tel: 81 3 3983 0086

IR SOUTHEAST ASIA: 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: 65 838 4630

IR TAIWAN: 16 Fl. Suite D..207, Sec.2, Tun Haw South Road, Taipei, 10673, Taiwan Tel: 886-2-2377-9936

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